

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10517272	WEILER ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	LENA NAJARIAN	3686

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
705	2, 3	7/10/09	LN
600	300	7/10/09	LN

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East (see attached printout) USPAT;US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	7/10/09	LN
updated previous searches	2/1/10	LN
updated previous searches	8/16/10	LN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>